



FQB13N50C/FQI13N50C

500V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

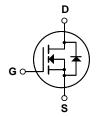
Features

- 13A, 500V, $R_{DS(on)} = 0.48\Omega @V_{GS} = 10 V$
- Low gate charge (typical 43nC)
- Low Crss (typical 20pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









Absolute Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Parameter		FQB13N50C / FQI13N50C	Units
V _{DSS}	Drain-Source Voltage		500	V
I _D	Drain Current - Continuous (T _C = 25°C	;)	13	Α
	- Continuous (T _C = 100°	C)	8	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	52	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	860	mJ
I _{AR}	Avalanche Current	(Note 1)	13	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	19.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_D	Power Dissipation (T _C = 25°C)		195	W
	- Derate above 25°C		1.56	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.64	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
R _{0JA} Thermal Resistance, Junction-to-Ambient			62.5	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$				V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.5		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V			1	μΑ
		V _{DS} = 400 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 6.5 A		0.39	0.48	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_{D} = 6.5 \text{ A}$ (Note	4)	15		S
Dynam i C _{iss}	ic Characteristics Input Capacitance	V - 25 V V - 0 V		1580	2055	pF
C _{oss}	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		180	235	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1.0 WILL		20	25	pF
Switchi	ing Characteristics			<u>I</u>	I	-
t _{d(on)}	Turn-On Delay Time	.,		25	60	ns
t _r	Turn-On Rise Time	$V_{DD} = 250 \text{ V}, I_{D} = 13 \text{ A},$		100	210	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25 \Omega$		130	270	ns
t _f	Turn-Off Fall Time	(Note 4,	5)	100	210	ns
Q _g	Total Gate Charge	V _{DS} = 400 V, I _D = 13 A,		43	56	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		7.5		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		18.5		nC
	Source Diode Characteristics a	nd Maximum Patings		1		
l _S	ource Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current				13	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				52	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 13 \text{ A}$			1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_{S} = 13 \text{ A,}$		410		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note	4)	4.5		μС

- Notes:
 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L =6.0 mH, I_{AS} = 13A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C 3. I_{SD} ≤ 13A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

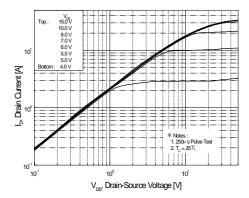


Figure 1. On-Region Characteristics

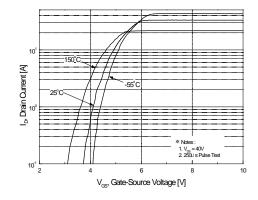


Figure 2. Transfer Characteristics

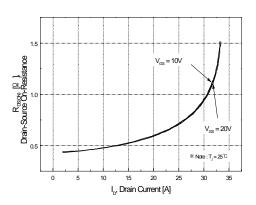


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

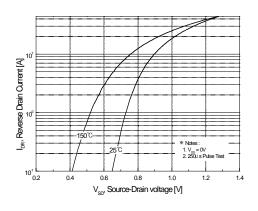


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

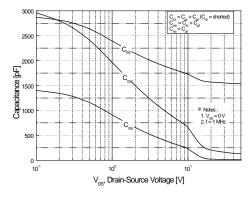


Figure 5. Capacitance Characteristics

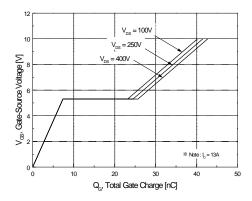


Figure 6. Gate Charge Characteristics

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Package Dimensions (Continued)

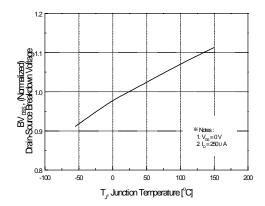
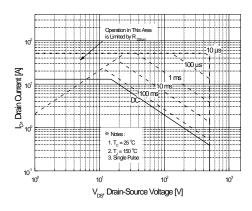


Figure 7. Breakdown Voltage Variation vs Temperature

Figure 8. On-Resistance Variation vs Temperature



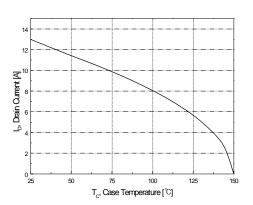


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs Case Temperature

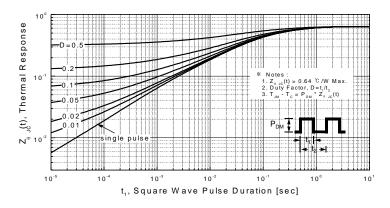
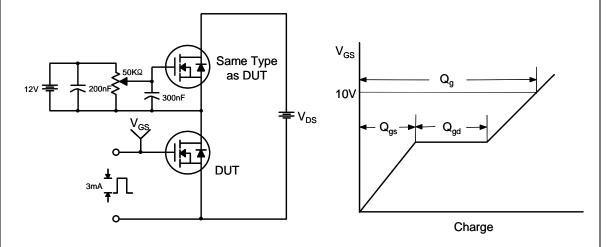


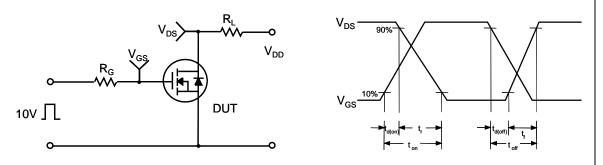
Figure 11. Transient Thermal Response Curve

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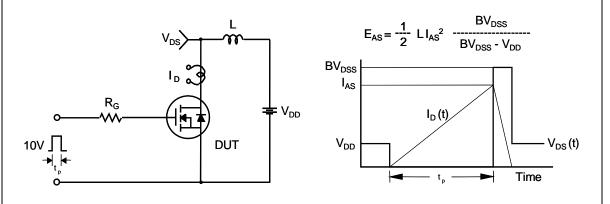
Gate Charge Test Circuit & Waveform



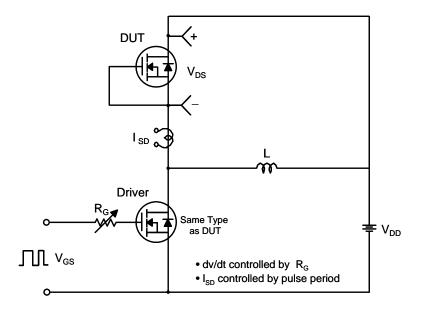
Resistive Switching Test Circuit & Waveforms

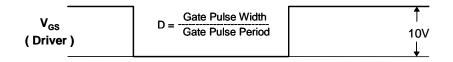


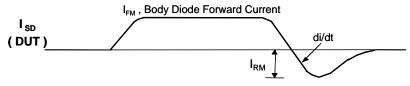
Unclamped Inductive Switching Test Circuit & Waveforms



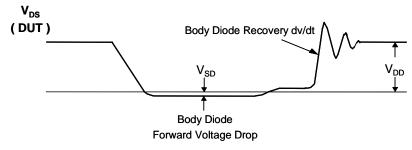
Peak Diode Recovery dv/dt Test Circuit & Waveforms





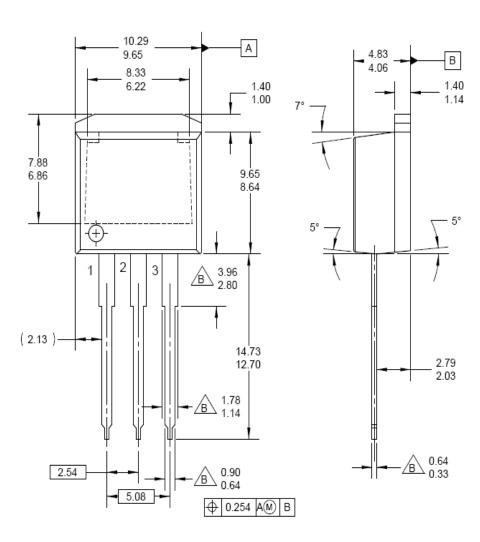


Body Diode Reverse Current



Mechanical Dimensions

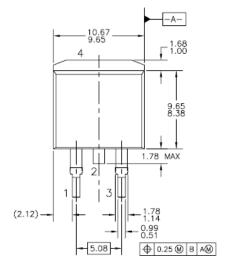
I² - PAK

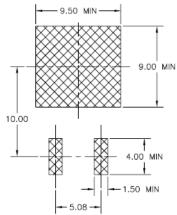


Dimensions in Millimeters

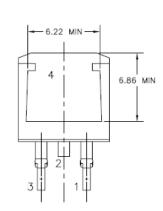
Mechanical Dimensions

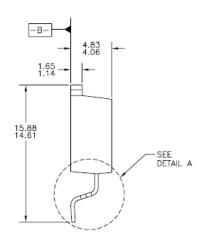
D² - PAK

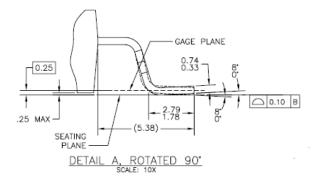




LAND PATTERN RECOMMENDATION







Dimensions in Millimeters





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